Search:

# Refine Search

### Search Results -

Term	Documents
(17 AND 34).PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD.	39
(L34 AND L17).PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD.	39

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## Search History

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Set Name side by side	Query	<u>Hit</u> Count	Set Name result set
DB=	PGPB, USPT, USOC, EPAB, JPAB, DWPI, TDBD; PLUR=YES; OP=OR		
<u>L39</u>	L34 and 117	39	<u>L39</u>
<u>L38</u>	L34 and 116	1	<u>L38</u>
<u>L37</u>	L34 and 115	6	<u>L37</u>
<u>L36</u>	L34 and 114	15	<u>L36</u>
<u>L35</u>	L34 and 112	101	<u>L35</u>
<u>L34</u>	19 and stack\$2	16741	<u>L34</u>
DB=	PGPB,USPT; PLUR=YES; OP=OR		
<u>L33</u>	19 and stack\$2	14922	<u>L33</u>
<u>L32</u>	19 and 117	140	<u>L32</u>
<u>L31</u>	19 and 116	14	<u>L31</u>
<u>L30</u>	19 and 115	54	<u>L30</u>

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<u>L29</u>	19 and 114	98	<u>L29</u>
<u>L28</u>	19 and 112	237	<u>L28</u>
<u>L27</u>	11 and 117	0	<u>L27</u>
<u>L26</u>	11 and 116	0	<u>L26</u>
<u>L25</u>	11 and 115	0	<u>L25</u>
<u>L24</u>	l1 and l14	0	<u>L24</u>
<u>L23</u>	11 and 112	1	<u>L23</u>
<u>L22</u>	111 and 117	0	<u>L22</u>
<u>L21</u>	111 and 116	0	<u>L21</u>
<u>L20</u>	111 and 115	0	<u>L20</u>
<u>L19</u>	111 and 114	1	<u>L19</u>
<u>L18</u>	111 and 112	22	<u>L18</u>
<u>L17</u>	(713/164)![CCLS]	305	<u>L17</u>
<u>L16</u>	(725/6)[CCLS]	67	<u>L16</u>
<u>L15</u>	(902/26)[CCLS]	171	<u>L15</u>
<u>L14</u>	(705/64)[CCLS]	608	<u>L14</u>
<u>L13</u>	(712/31-38)[CCLS]	1420	<u>L13</u>
<u>L12</u>	(712/31-38)![CCLS]	1420	<u>L12</u>
DB=	PGPB,USPT,USOC,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR		
<u>L11</u>	19 and stack\$2 near55 register\$1 near4 (file or bank or group\$4 or plur\$7 or multiple)	409	<u>L11</u>
<u>L10</u>	L9 near45 11	0	<u>L10</u>
<u>L9</u>	(security or permission\$1 or permit\$3 or protect\$5) near5 (rom\$1 or memor\$4 or ram\$1 or eeprom\$1 or storage\$1)	124849	<u>L9</u>
DB=	PGPB; PLUR=YES; OP=OR		
<u>L8</u>	(712/2-300)[CCLS]	2278	<u>L8</u>
DB=	PGPB, USPT; PLUR=YES; OP=OR		
<u>L7</u>	(712/2-300)![CCLS]	11885	<u>L7</u>
DB=	PGPB, USPT, USOC, EPAB, JPAB, DWPI, TDBD; PLUR=YES; OP=OR		
<u>L6</u>	11 near55 (select\$5)	5	<u>L6</u>
<u>L5</u>	(free or user\$1) near6 (programming or programmable or program\$3) near85 L1	1	<u>L5</u>
<u>L4</u>	(free or user\$1) near6 (programming or programmable or programs3) near85 L1	1	<u>L4</u>
<u>L3</u>	(free or user\$1) near6 (programming or programmable or program\$3) and L1	30	<u>L3</u>
<u>L2</u>	(free or user\$1) near6 (programming or programmable or program\$3) near45 L1	1	<u>L2</u>
<u>L1</u>	(register\$1) near4 (file or bank or group\$4 or plur\$7 or multiple) near35 (indicat\$5 or specif\$5) near8 (value\$ or content\$1 or data) near12 (read\$3 or stor\$3 or writ\$5 or written) near25 stack\$2	78	<u>L1</u>

# END OF SEARCH HISTORY



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IEE CNF	IEE Conference Proceeding			Electron Device Letters, IEEE		J.E.; Carter, D.E.; Pinizzotto, R	F.; Coleman,
KIHE SYD	IEEE Standard			Volume 5, Issue 10, Oct 198	4 Page(s):428 - 429		
				AbstractPlus   Full Text: PDF( Rights and Permissions	232 KB) IEEE JNL		
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Volume 6, Issue 3, June 1998 Page(s):262 - 273 Digital Object Identifier 10.1109/90.700890

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